Search Notes				
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Application/Control No.	Applicant(s)/Patent under Reexamination
10/771,527	HAGINO, HIROSHI
Examiner	Art Unit

Patricia Leith

1655

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEAR (INCLUDING SE	CH NOTES EARCH STRATEG	Y)
	DATE	EXMR
updated EAST	7/9/2006	PL